捷多邦,专业PCB打样工厂,24小时加急出货



OKI Semiconductor

ML7074-003 GA

VoIP CODEC

GENERAL DESCRIPTION

The ML7074-003GA is a speech CODEC for VoIP. This LSI allows selection of G.729.A, G.726, or G.711 standard as a speech CODEC. The LSI is optimum for adding VoIP functions to TAs, routers, etc., since it has the functions of an echo canceller for 32 msec delay, DTMF detection, tone detection, tone generation, etc.

FEATURES

- Single 3.3 V power supply operation (DV_{DD}0, 1, 2, AV_{DD}: 3.0 to 3.6 V)
- Speech CODEC:
 - Selectable among G.729.A (8 kbps), G726 (32 kbps), G.711 (64 kbps) µ-law, and A-law NWW.DZSC.CON Mutual conversion function between G.729.A (8 kbps) and G.726 (32 kbps).
- Echo canceller for 32 ms delay •
- DTMF detect function .
- Tone detect function: 2 systems (1650 Hz, 2100 Hz: Detect frequency can be changed.)
- Tone generate function
- FSK generate function
- Dial pulse detect function •
- Dial pulse transmit function
- Internal 1-channel 16-bit timer
- Built-in FIFO buffers (640 bytes) for transferring transmit and receive data Frame/DMA (slave) interface selectable.
- Master clock frequency: 4.096 MHz (crystal oscillation or external input) ٠
- Hardware or software power down operation possible.
- Analog input/output type: •

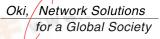
Two built-in input amplifiers, $10 \text{ M}\Omega$ driving

- Two built-in output amplifiers, $10 \text{ k}\Omega$ driving
- Package:

64-pin plastic QFP (QFP64-P-1414-0.80-BK)

Ordering part number: ML7074-003GA

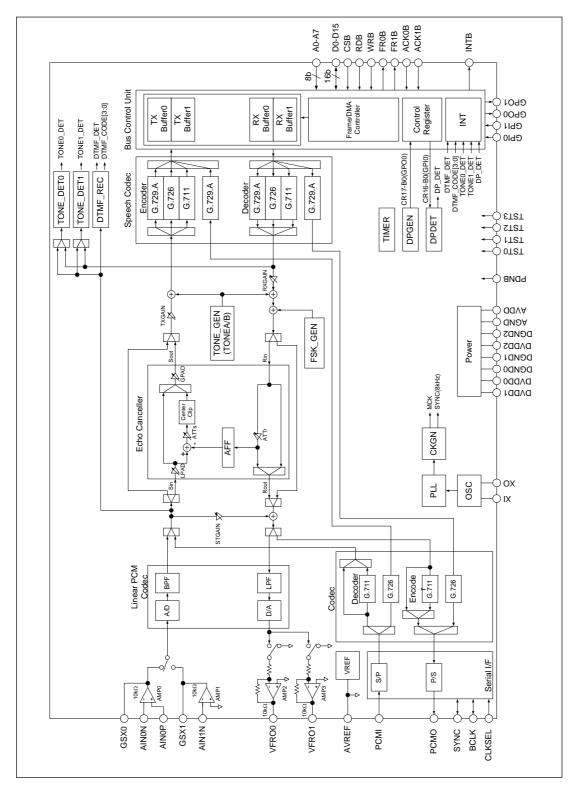




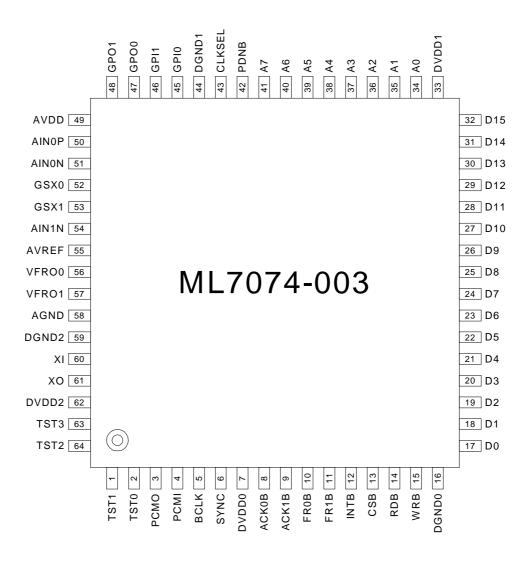
FEDL7074-003DIGEST-01

Issue Date: Oct. 27, 2003

BLOCK DIAGRAM



PIN ASSIGNMENT (TOP VIEW)



64-pin plastic QFP

ML7074-003 GA

PIN DESCRIPTIONS

Pin No.	Symbol	I/O	PDNB = "0"	Description
1	TST1	Ι	"0"	Test control input 1: Normally input "0".
2	TST0	Ι	"0"	Test control input 0: Normally input "0".
3	PCMO	0	"Hi-z"	PCM data output
4	PCMI	I	I	PCM data input
			1	CLKSEL = "0"
5	BCLK	I/O	I	PCM shift clock input
5	DOLK	1/0	"L"	CLKSEL = "1"
			L	PCM shift clock output
			1	CLKSEL = "0"
6	SYNC	I/O	I	PCM sync signal 8 kHz input
0	SINC	1/0	"L"	CLKSEL = "1"
			L	PCM sync signal 8 kHz output
7	DV _{DD} 0			Digital power supply
8	ACK0B	I	I	Transmit buffer DMA access acknowledge signal input
9	ACK1B	Ι	I	Receive buffer DMA access acknowledge signal input
				FR0B: (CR11-B7 = "0")
10	FR0B	0	"H"	Transmit buffer frame signal output
10	(DMARQ0B)	0	п	DMARQ0B: (CR11-B7 = "1")
				Transmit buffer DMA access request signal output
				FR1B: (CR11-B7 = "0")
11	FR1B	0	"H"	Receive buffer frame signal output
	(DMARQ1B)	Ŭ		DMARQ1B: (CR11-B7 = "1")
				Receive buffer DMA access request signal output
12	INTB	0	"H"	Interrupt request output
		Ŭ		"L" level is output for about 1.0 μ sec when an interrupt is generated.
13	CSB	I	I	Chip select control input
14	RDB	Ι	I	Read control input
15	WRB	Ι	I	Write control input
16	DGND0		I	Digital ground (0.0 V)
17	D0	I/O	I	Data input/output
18	D1	I/O	I	Data input/output
19	D2	I/O	I	Data input/output
20	D3	I/O	I	Data input/output
21	D4	I/O		Data input/output
22	D5	I/O		Data input/output
23	D6	I/O		Data input/output
24	D7	I/O		Data input/output
25	D8	I/O	ı	Data input/output
20	Do	1/0	I	Fix to input state when using in 8-bit bus access (CR11-B5 = "1").

FEDL7074-003FULL-01

OKI Semiconductor

ML7074-003 GA

26	D9	I/O	I	Data input/output
				Fix to input state when using in 8-bit bus access (CR11-B5 = "1"). Data input/output
27	D10	I/O	I	Fix to input state when using in 8-bit bus access (CR11-B5 = "1").
28	D11	I/O	I	Data input/output Fix to input state when using in 8-bit bus access (CR11-B5 = "1").
29	D12	I/O	1	Data input/output
	012		•	Fix to input state when using in 8-bit bus access (CR11-B5 = "1").
30	D13	I/O	Ι	Data input/output Fix to input state when using in 8-bit bus access (CR11-B5 = "1").
31	D14	I/O	Ι	Data input/output Fix to input state when using in 8-bit bus access (CR11-B5 = "1").
32	D15	I/O	I	Data input/output
33	DV _{DD} 1			Fix to input state when using in 8-bit bus access (CR11-B5 = "1"). Digital power supply
		-		
34			-	Address input
35	A1		<u> </u>	Address input
36	A2			Address input
37	A3	Ι		Address input
38	A4	Ι		Address input
39	A5			Address input
40	A6	I	I	Address input
41	A7	I	I	Address input
				Power down input
42	PDNB	I	"0"	"0": Power down reset
				"1": Normal operation
				SYNC and BCLK I/O control input
43	CLKSEL	I	I	"0": SYNC and BCLK become inputs
				"1": SYNC and BCLK become outputs
44	DGND1	-		Digital ground (0.0 V)
45	GPI0	I	I	General-purpose input pin 0 (5 V tolerant input)
40		+ . +		/Secondary function: Dial pulse detect input pin
46	GPI1			General-purpose input pin 1 (5 V tolerant input)
47	GPO0	0	"["	General-purpose output pin 0 (5 V tolerant output, can be pulled up externally)
47	GFOU	0	L	/Secondary function: Dial pulse transmit pin
				General-purpose output pin 1 (5 V tolerant output, can be pulled up
48	GPO1	0	"L"	externally)
49	AV _{DD}			Analog power supply
50	AINOP	Ι		AMP0 non-inverted input
51	AINON	Ι	I	AMP0 inverted input
52	GSX0	0	"Hi-z"	AMP0 output (10 kΩ driving)
53	GSX1	0	"Hi-z"	AMP1 output (10 kΩ driving)
54	AIN1N	Ι		AMP1 inverted input
55	AVREF	0	"L"	Analog signal ground (1.4 V)

FEDL7074-003FULL-01

OKI Semiconductor

ML7074-003 GA

VFRO0	0	"Hi-z"	AMP2 Output (10 kΩ driving)
VFRO1	0	"Hi-z"	AMP3 Output (10 kΩ driving)
AGND			Analog ground (0.0 V)
DGND2			Digital ground (0.0 V)
XI	Ι		4.096 MHz crystal oscillator I/F, 4.096 MHz clock input
XO	0	"H"	4.096 MHz crystal oscillator I/F
$DV_{DD}2$			Digital power supply
TST3	Ι	"0"	Test control input 3: Normally input "0".
TST2	Ι	"0"	Test control input 2: Normally input "0".
	VFRO1 AGND DGND2 XI XO DV _{DD} 2 TST3	VFRO1 O AGND DGND2 XI I XO O DV _{DD} 2 TST3 I	VFRO1 O "Hi-z" AGND DGND2 XI I I XO O "H" DV _{DD} 2 TST3 I "0"

ML7074-003 GA

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Conditions	Rating	Unit
Analog power supply voltage	VDA		-0.3 to 5.0	V
Digital power supply voltage	V _{DD}		-0.3 to 5.0	V
Analog input voltage	VAIN	Analog pins	–0.3 to V _{DD} + 0.3	V
Digital input valtage	VDIN1	Normal digital pins	–0.3 to V _{DD} + 0.3	V
Digital input voltage	VDIN2	5 V tolerant pins	-0.3 to 6.0	V
Storage temperature range	Tstg		-55 to +150	°C

RECOMMENDED OPERATING CONDITIONS

(Unless otherwise specified, AV_{DD} = 3.0 to 3.6 V, DV_{DD} 0, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Analog power supply voltage	VDA		3.0	3.3	3.6	V
Digital power supply voltage	V _{DD}		3.0	3.3	3.6	V
Operating temperature range	Та		-20	_	60	°C
Digital high level input voltage	VIH1	Digital input pins	2.0	_	V _{DD} + 0.3	V
	VIH2	GPI0 and GPI1 pins	2.0	_	5.5	V
Digital low level input voltage	VIL	Digital pins	-0.3	_	0.8	V
Digital input rise time	tIR	Digital pins	_	2	20	ns
Digital input fall time	tIF	Digital pins		2	20	ns
Digital output load capacitance	CDL	Digital pins		_	50	pF
Capacitance of bypass capacitor for AVREF	Cvref	Between AVREF and AGND	2.2+0.1		4.7+0.1	μF
Master clock frequency	Fmck	MCK	-0.01%	4.096	+0.01%	MHz
PCM shift clock frequency	Fbclk	BCLK (at input)	64	_	2048	kHz
PCM sync signal frequency	Fsync	SYNC (at input)		8.0		kHz
Clock duty ratio	DRCLK	MCK, BCLK (at input)	40	50	60	%
PCM sync timing	tBS	BCLK to SYNC (at input)	100			ns
	tSB	SYNC to BCLK (at input)	100			ns
PCM sync signal width	tWS	SYNC (at input)	1BCLK		100	μS

ELECTRICAL CHARACTERISTICS

DC Characteristics

(Unless otherwise specified, AV_{DD} = 3.0 to 3.6 V, DV_{DD} 0, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Power supply current	ISS	Standby state (PDNB = "0", V _{DD} = 3.3 V, Ta = 25°C)	—	5.0	20.0	μA
	I _{DD} 1	Operating state 1 In the PCM/IF mode (SC_EN = "1", PCMIF_EN = "1", AFE_EN = "1", TRANS_EN = "1") Connect a 4.096 MHz crystal oscillator between XI and XO.		45.0	55.0	mA
	I _{DD} 2	Operating state 2 When operating the whole system (SC_EN = "1", PCMIF_EN = "0", TRANS_EN = "0", AFE_EN = "0") Connect a 4.096 MHz crystal oscillator between XI and XO.		50.0	65.0	mA
Digital input pin	IIH	$Vin = DV_{DD}$		0.01	1.0	μA
input leakage current	IIL	Vin = DGND	-1.0	-0.01	_	μA
Digital I/O pin	IOZH	$Vout = DV_{DD}$		0.01	1.0	μA
output leakage current	IOZL	Vout = DGND	-1.0	-0.01		μA
High level output voltage	VOH	Digital output pins, I/O pins IOH = 4.0 mA IOH = 1.0 mA (XO pin)	2.2			V
Low level output voltage	VOL	Digital output pins, I/O pins IOL = -4.0 mA IOL = -1.0 mA (XO pin)		_	0.4	V
Input capacitance *1	CIN	Input pins		8	12	pF

Note: *1 Guaranteed design value

ML7074-003 GA

Analog Interface (Unless otherwise specified, AV_{DD} = 3.0 to 3.6 V, DV_{DD} 0, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Input resistance *1	RIN	AINON, AINOP, AIN1N	10			MΩ
Output load resistance	RL	GSX0, GSX1, VFRO0, VFRO1	10			kΩ
Output load capacitance	CL	Analog output pins	_		50	pF
Offset voltage	VOF	VFRO0, VFRO1	-40		40	mV
Output voltage level *2	VO	GSX0, GSX1, VFRO0, VFRO1 RL = 10 kΩ	_		1.3	Vpp

Notes:

*1 Guaranteed design value *2 -7.7 dBm (600Ω) = 0 dBm0, +3.17 dBm0 = 1.3 Vpp

ML7074-003 GA

AC Characteristics

CODEC (Speech CODEC in G.711 (μ -law) Mode) (Unless otherwise specified, AV_{DD} = 3.0 to 3.6 V, DV_{DD}0, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Condition	ons	Min.	Typ	Max.	Unit
Falameter	•	Frequency (Hz)	Level (dBm0)		Тур.	IVIAX.	
	LT1	0 to 60		25			dB
	LT2	300 to 3000		-0.15		0.20	dB
Transmit frequency	LT3	1020	- 0	Refe			
characteristics	LT4	3300	0	-0.15		0.80	dB
	LT5	3400		0		0.80	dB
	LT6	3968.75		13			dB
	LR2	0 to 3000		-0.15		0.20	dB
Receive frequency	LR3	1020			erence v	alue	
characteristics	LR4	3300	0	-0.15		0.80	dB
	LR5	3400		0		0.80	dB
	LR6	3968.75		13			dB
	SDT1		3	35		_	dBp
Transmit signal to noise	SDT2		0	35		_	dBp
ratio [*1]	SDT3	1020	-30	35			dBp
	SDT4		-40	28			dBp
	SDT5		-45	23			dBp
Receive signal to noise	SDR1	1020	3	35			dBp
	SDR2		0	35			dBp
ratio [*1]	SDR3		-30	35			dBp
	SDR4		-40	28			dBp
	SDR5		-45	23		_	dBp
	GTT1		3	-0.2		0.2	dB
Transmit inter-level	GTT2		-10		erence v	_	
loss error	GTT3	1020	-40	-0.2		0.2	dB
	GTT4		-50	-0.6		0.6	dB
	GTT5		-55	-1.2		1.2	dB
	GTR1		3	-0.2		0.2	dB
Receive inter-level loss	GTR2		-10		erence v	alue	
error	GTR3	1020	-40	-0.2		0.2	dB
	GTR4		-50	-0.6		0.6	dB
	GTR5		-55	-1.2		1.2	dB
Idle channel noise	NIDLT	_	Analog input = AVREF		_	-68	dBm0p
[*1]	NIDLR		PCMI = "1"			-72	dBm0p
Transmit absolute level [*2]	AVT	1020	0	0.285	0.320	0.359	Vrms
Receive absolute level [*2]	AVR	1020	0	0.285	0.320	0.359	Vrms
Power supply noise	PSRRT	Noise frequency		30			dB
reject ratio	PSRRR	range: 0 to 50 kHz Noise level: 50mVpp	_	30			dB

Notes: *1 Using P-message filter

*2 0.320 Vrms = 0 dBm0 = -7.7 dBm (600Ω)

Gain Setting (Speech CODEC in G.711 (µ-law) Mode)

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Transmit and receive gain setting accuracy	GAC	_	-1.0		1.0	dB

Tone Output (Speech CODEC in G.711 (µ-law) Mode)

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Frequency deviation	fDFT	Relative to set frequency	-1.5	_	1.5	%
Output level	oLEV	Relative to set gain	-2.0		2.0	dB

DTMF Detector, Other Detectors (Speech CODEC in G.711 (µ-law) Mode)

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

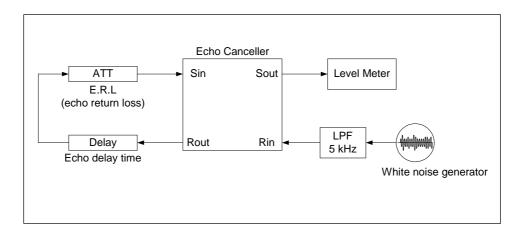
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Detect level accuracy	dLAC	Relative to set detect level	-2.5		2.5	dB

Echo Canceller

(Unless otherwise specified, AV_{DD} = 3.0 to 3.6 V, DV_{DD} 0, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Echo attenuation	eRES	In the analog I/F mode In the PCM I/F (16-bit linear) mode In the PCM I/F (G.711) mode		35 30		dB
Erasable echo delay time	tECT				32	ms

Measurement method



PDNB, XO, AVREF Timings

(Unless otherwise specified, AV_{DD} = 3.0 to 3.6 V, DV_{DD} 0, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Power down signal pulse width	tPDNB	PDNB pin	1			μS
Oscillation start-up time	txtal			2+α	100	ms
AVREF rise time	tAVREF	AVREF = 1.4 (90%) C5 = 4.7 μF, C6 = 0.1 μF (See Fig. 9.)			600	ms
Initialization mode start-up time	tINIT			1		s

* α is a value that depends on the oscillation stabilizing time when using a crystal oscillator.

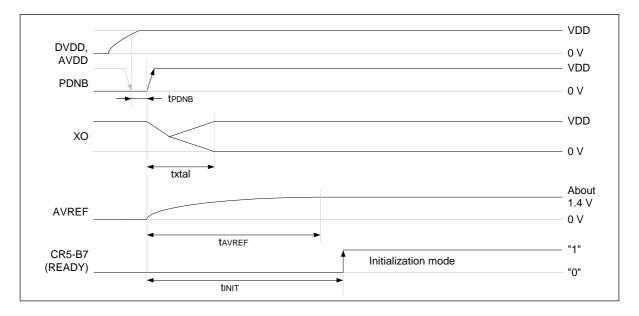


Fig. 1 PDNB, XO, and AVREF timings

ML7074-003 GA

PCM I/F Mode

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to +60°C)

Paraméter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Bit clock frequency	fBCLK	CDL = 20pF(at output)	-0.1%	64	+0.1%	kHz
Bit clock duty ratio	dBCLK	CDL = 20pF(at output)	45	50	55	%
Sync signal frequency	fSYNC	CDL = 20pF(at output)	-0.1%	8	+0.1%	kHz
Supervisional duty ratio	dSYNC1	CDL = 20pF(at output) At 64 kHz output	12.4	12.5	12.6	%
Sync signal duty ratio	dSYNC2	CDL = 20pF(at output) At 128 kHz output	6.24	6.25	6.26	%
Transmit/receive signal sync	tBS	BCLK to SYNC (at output)	100	_	_	ns
timing	tSB	SYNC to BCLK (at output)	100	_	_	ns
Input setup time	tDS		100	_	—	ns
Input hold time	tDH		100		_	ns
Distitut automatical algorithms a	tSDX			_	100	ns
Digital output delay time	tXD1	PCMO pin Pull-up, pull-down resistors			100	ns
Digital output hold time	tXD2	RDL = 1 k Ω , CDL = 50 pF			100	ns
Digital output hold time	tXD3	$1000 = 1 \text{ M}_2, \text{ ODE} = 30 \text{ pl}$			100	ns

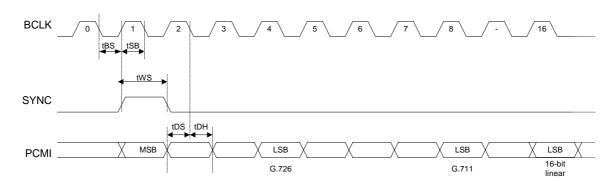


Fig. 2 PCM I/F mode input timing (long frame)

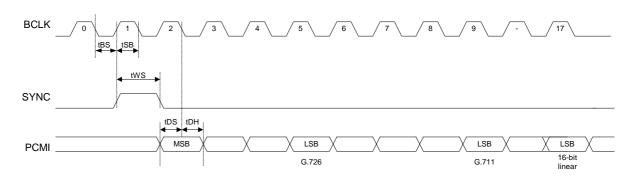


Fig. 3 PCM I/F mode input timing (short frame)

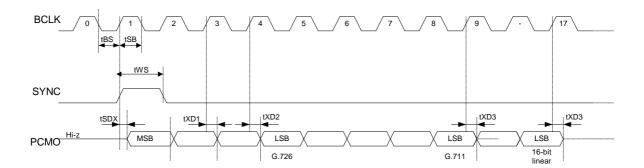


Fig. 4 PCM I/F mode output timing (long frame)

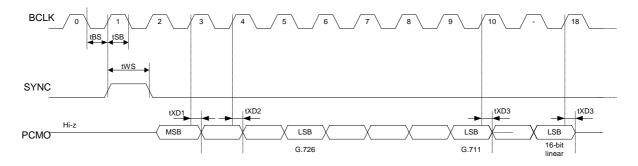


Fig. 5 PCM I/F mode output timing (short frame)

ML7074-003 GA

Control Register Interface

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to $+60^{\circ}C$)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Address setup time	tAS		10	_		ns
Address hold time	tAH		10			ns
Write data setup time	tWDS		10			ns
Write data hold time	tWDH		10	_		ns
CSB setup time	tCS		10			ns
CSB hold time	tCH	CL = 50 pF	10			ns
WRB pulse width	tWW		10			ns
Read data output delay time	tRDD				20	ns
Read data output hold time	tRDH		3			ns
RDB pulse width	tRW		25			ns
CSB disable time	tCD		10			ns

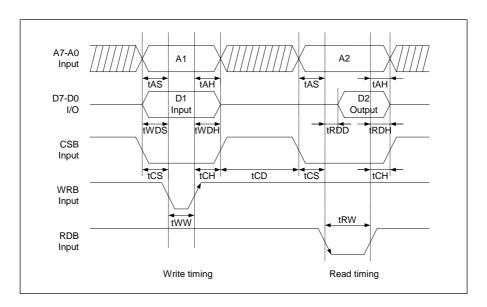


Fig. 6 Control register interface

ML7074-003 GA

Transmit and Receive Buffer Interface (in Frame Mode)

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to $+60^{\circ}C$)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
FR1B setup time	tF1S		3			ns
FR1B output delay time	tF1D				20	ns
Address setup time	tAS		10			ns
Address hold time	tAH		10			ns
Write data setup time	tWDS		10			ns
Write data hold time	tWDH		10			ns
CSB setup time	tCS		10			ns
CSB hold time	tCH	CL = 50 pF	10			ns
WRB pulse width	tWW		10			ns
FR0B setup time	tF0S		3			ns
FR0B output delay time	tF0D				20	ns
Read data output delay time	tRDD				30	ns
Read data output hold time	tRDH		3			ns
RDB pulse width	tRW		35			ns
CSB disable time	tCD		10			ns

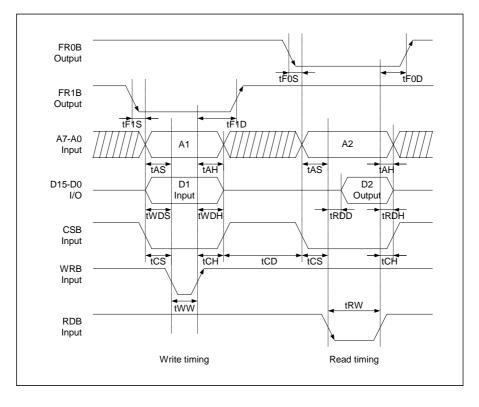


Fig. 7 Transmit and receive buffer interface (in frame mode)

ML7074-003 GA

Transmit and Receive Buffer Interface (in DMA Mode)

(Unless otherwise specified, $AV_{DD} = 3.0$ to 3.6 V, $DV_{DD}0$, 1, 2 = 3.0 to 3.6 V, AGND = DGND0, 1, 2 = 0.0 V, Ta = -20 to $+60^{\circ}C$)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
DMARQ1B setup time	tDR1S		3			ns
	tDR1RD			_	25	ns
DMARQ1B output delay time	tDR1FD			_	25	ns
Address setup time	tAS		10	_		ns
Address hold time	tAH		10	_		ns
Write data setup time	tWDS		10			ns
Write data hold time	tWDH		10			ns
ACK setup time	tAKS	CL = 50 pF	10	_		ns
ACK hold time	tAKH		10	_		ns
WRB pulse width	tWW		10			ns
DMARQ0B setup time	tDR0S		3			ns
DMARQ0B output delay time	tDR0RD				20	ns
DWARQOB Output delay time	tDR0FD			_	25	ns
Read data output delay time	tRDD				30	ns
Read data output hold time	tRDH		3			ns
RDB pulse width	tRW		35			ns
ACKB disable time	tAD		10			ns

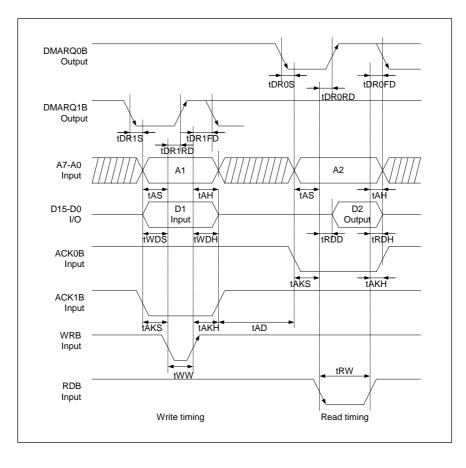


Fig. 8 Transmit and receive buffer interface (in DMA mode)

PIN FUNCTION DESCRIPTIONS

AINON, AINOP, GSX0, AIN1N, GSX1

These are the analog transmit input and transmit level adjust pins. Each of AIN0N and AIN1N is connected to each of the inverting input pins of the built-in transmit amplifiers AMP0 and AMP1, and AIN0P is connected to the non-inverting input pin of AMP0. In addition, GSX0 and GSX1 are connected to the output pins of AMP0 and AMP1, respectively. The selection between AMP0 and AMP1 is made by CR10-B0. See Fig. 9 for the method of making level adjustment. During the power down mode (when PDNB = "0" or CR0-B7 = "1"), the outputs of GSX0 and GSX1 go to the high impedance state. If AMP0 is not used in the specific application of this LSI, short GSX0 with AIN0N and connect AIN0P with AVREF. When AMP1 is not used, short GSX1 with AIN1N.

Notice:

It is recommended to select the amplifier to be used before the conversation starts, since a small amount of noise will be generated if the amplifier selection is changed while conversation is in progress.

VFRO0, VFRO1

These are analog receive output pins and are connected to the output pins of the built-in receive amplifiers AMP2 and AMP3, respectively. The output signals of VFRO0 and VFRO1 can be selected using CR10-B1 and CR10-B2, respectively. When selected ("1"), the received signal will be output, and when deselected ("0"), the AVREF signal (about 1.4 V) will be output. In the power down mode, these pins will be in the high impedance state. It is recommended to use these output signals via DC coupling capacitors.

Notice:

It is recommended to select the amplifier to be used before the conversation starts, since a small amount of noise is generated if the output selection is changed while the conversation is in progress.

At the time of resetting or releasing from the reset state, it is recommended to select the AVREF as outputs of VFRO0 and VFRO1.

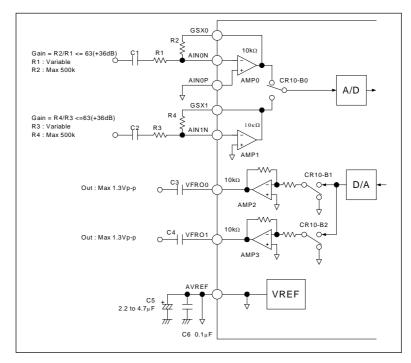


Fig. 9 Analog interface

AVREF

This is the output pin for the analog signal ground potential. The output potential at this pin will be about 1.4 V. Connect a 2.2 to 4.7 μ F (aluminum electrolytic type) capacitor and a 0.1 μ F (ceramic type) capacitor in parallel between this pin and the GND pin as bypass capacitors. The output at the AVREF pin goes to 0.0 V in the power down mode. The voltage starts rising after the power down mode is released (PDNB = "1" and also CR0-B7 = "0"). The rise time is about 0.6 sec.

XI, XO

These are the pins for either connecting the crystal oscillator for the master clock or for inputting an external master clock signal.

The oscillations of the master clock oscillator will be stopped during a power down due to the PDNB signal or during a software power down due to CR0-B7 (SPDN). The oscillations start when the power down condition is released, and the internal clock supply of the LSI will be started after counting up the oscillation stabilization period (of about 16 ms). Examples of crystal oscillator connection and external master clock input are shown in Fig. 10.

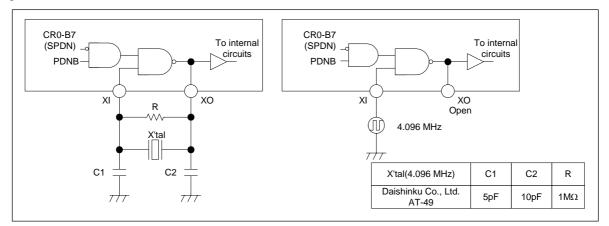


Fig. 10 Examples of oscillator circuit and clock input

PDNB

This is the power down control input pin. The power down mode is entered when this pin goes to "0". In addition, this pin also has the function of resetting the LSI. In order to prevent wrong operation of the LSI, carry out the initial power-down reset after switching on the power using this PDNB pin. Also, keep the PDNB pin at "0" level for 1 µs or more to initiate the power down state.

Further, it is possible to carry out a power down reset of the LSI when the power is being supplied by performing control of CR0-B7 (SPDN) in the sequence " $0" \rightarrow "1" \rightarrow "0"$.

The READY signal (CR5-B7) goes to "1" about 1.0 second after the power down mode is released thereby entering the mode of setting various functions (initialization mode). See Fig. 1 for the timings of PDNB and AVREF, XO, and the initialization mode.

Notice: At the time of switching on the power, start from the power down mode using PDNB.

$DV_{DD}0$, $DV_{DD}1$, $DV_{DD}2$, AV_{DD}

These are power supply pins. $DV_{DD}0$, 1, 2 are the power supply pins for the digital circuits while AV_{DD} is the power supply pin for the analog circuits of the LSI. Connect these pins together in the neighborhood of the LSI and connect as bypass capacitors a 10 μ F electrolytic capacitor and a 0.1 μ F ceramic capacitor in parallel between the DGND and AGND pins.

DGND0, DGND1, DGND2, AGND

These are ground pins. GDND0, 1, 2 are the ground pins for the digital circuits and AGND is the ground pin for the analog circuits of the LSI. Connect these pins together in the neighborhood of the LSI.

TST0, TST1, TST2, TST3

These are input pins for testing purposes only. Keep the inputs to these pins at the "0" level during normal use conditions.

INTB

This is the interrupt request output pin. An "L" level is output for a duration of about 1.0 μ sec at this pin when there is a change in state of an interrupt cause.

This output will be maintained at the "H" level when there is no change in state of any of the interrupt causes. The actual interrupt cause generating the interrupt can be verified by reading CR3 and CR4. The different interrupt causes are described below.

• Underflow error (CR3-B0)

An interrupt is generated when an internal read from the receive buffer occurs before the writing into the receive buffer from the MCU has been completed.

An interrupt is generated when a normal writing is made in the receive buffer by the MCU and the underflow error is released.

• Overrun error (CR3-B1)

An interrupt is generated when an internal write of the next data into the transmit buffer occurs before the transmit buffer data read out from the MCU has been completed.

An interrupt is generated when a normal read out is made from the transmit buffer by the MCU and the overrun error is released.

- When a dial pulse is detected (CR4-B6).
- When a DTMF signal is detected (CR4-B4).

• When DTMF_CODEC0, 1, 2, 3 are detected (CR4-B0, B1, B2, B3). An interrupt is generated when a DTMF signal is detected. An interrupt is generated when there is a change from the DTMF signal detected state to the no-detected state. An interrupt is generated when there is a change in the detected code (CR4-B0, B1, B2, B3) in the condition in which a DTMF signal is being detected.

• When TONE0 is detected (CR3-B3).

An interrupt is generated when a 1650 Hz tone signal is detected. An interrupt is generated when there is a change to the non-detection condition in the tone signal detection condition.

- When TONE1 is detected (CR3-B4). An interrupt is generated when a 2100 Hz tone signal is detected. An interrupt is generated when there is a change to the non-detection condition in the tone signal detection condition.
- When FGEN_RQ is generated (CR3-B6). An interrupt is generated when the FSK generator makes a request for the next data to be transmitted. An interrupt is generated when there is a change from the condition in which the FSK generator is requesting for
- transmission data to the condition in which there is no request for internal fetch of the data to be transmitted next.
- When DSP_ERR is detected (CR3-B7). An interrupt is generated when any error occurs in the DSP inside the LSI.

A0 to A7

These are the address input pins for use during an access of the frame, DMA, or control registers. The different addresses will be the following. Transmit buffer (TX Buffer) A7 to A0 = 10xxxxxb (the lower 6 bits are not valid) Receive buffer (RX Buffer) A7 to A0 = 01xxxxxb (the lower 6 bits are not valid) Control register (CR) A7 to A0 = 00xxxxxb

D0 to D15

These are the data input/output pins for use during an access of the frame, DMA, or control registers. Connect pull-up resistors to these pins since they are I/O pins. When the 8-bit bus access method is selected by CR11-B5, only D0 to D7 become valid. Since the higher 8 bits D8 to D15 will always be in the input state when the 8-bit bus access method is selected (CR11-B5 = "1"), tie them to "0" or "1" inputs.

CSB

This is the chip select input pin for use during a frame or control register access.

RDB

This is the read enable input pin for use during a frame, DMA, or control register access.

WRB

This is the write enable input pin for use during a frame, DMA, or control register access.

ML7074-003 GA

FR0B (DMARQ0B)

• FR0B (In frame mode, CR11-B7 = "0") This is the transmit frame output pin which outputs the signal when the transmit buffer is full during frame

access. This pin outputs an "L" level when the transmit buffer becomes full, and maintains that "L" level output until a specific number of words are read out from the MCU.

DMARQ0B (In DMA mode, CR11-B7 = "1")
 This is the DMA request output pin which outputs the signal when the transmit buffer is full during DMA access.
 This output becomes "L" when the transmit buffer becomes full, and returns to the "H" level automatically on the falling edge of the read enable signal (RDB = "1" → "0") when there is an acknowledgement signal (ACK0B = "0") from the MCU. This relationship is repeated until a specific number of words are read out from the MCU.

FR1B (DMARQ1B)

• FR1B (In frame mode, CR11-B7 = "0")

This is the receive frame output pin which outputs the signal when the receive buffer is empty during frame access. This pin outputs an "L" level when the receive buffer becomes empty, and maintains that "L" level output until a specific number of words are written from the MCU.

• DMARQ1B (In DMA mode, CR11-B7 = "1")

This is the DMA request output pin which outputs the signal when the receive buffer is empty during DMA access. This output becomes "L" when the receive buffer becomes empty, and returns to the "H" level automatically on the falling edge of the write enable signal (WRB = "1" \rightarrow "0") when there is an acknowledgement signal (ACK1B = "0") from the MCU. This relationship is repeated until a specific number of words are written from the MCU.

ACK0B

This is the DMA acknowledgement input pin for the DMARQ0B signal during DMA access of the transmit buffer and becomes valid in the DMA mode (CR11-B7 = "1").

Tie this pin to "1" when using this LSI in the frame access mode (CR11-B7 = "0").

ACK1B

This is the DMA acknowledgement input pin for the DMARQ1B signal during DMA access of the receive buffer and becomes valid in the DMA mode (CR11-B7 = "1"). Tie this pin to "1" when using this LSI in the frame access mode (CR11-B7 = "0").

GPI0, GPI1

These are general-purpose input pins. The state ("1" or "0") of each of these GPI0 and GPI1 pins can be read out respectively from CR16-B0 and CR16-B1. Further, GPI0 becomes the input pin for the dial pulse detector (DPDET) in the secondary functions.

GPO0, GPO1

These are general-purpose output pins. The values set in CR17-B0 and CR17-B1 are output at these pins GPO0 and GPO1, respectively. Further, GPO0 becomes the output pin for the dial pulse generator (DPGEN) in the secondary functions.

FEDL7074-003FULL-01

ML7074-003 GA

CLKSEL

This is the input/output control input pin of SYNC and BCLK. The pin becomes input at "0" level and output at "1" level.

SYNC

This is the 8 kHz sync signal input/output pin of PCM signals. When CLKSEL is "0", input continuously an 8 kHz clock synchronous with BCLK. Further, when CLKSEL is "1", this pin outputs an 8 kHz clock synchronous with BCLK. Long frame synchronization is used when CR0-B1 (LONG/SHORT) is "0" and short frame synchronization is used when it is "1".

BCLK

This is the shift clock input/output pin for the PCM signal. When CLKSEL is "0", it is necessary to input to this pin a clock signal that is synchronous with SYNC. Input a 64 to 2048 kHz clock when the G.711 mode or the G.726 mode has been selected, and input a 128 to 2048 kHz clock when the 16-bit linear mode has been selected. When CLKSEL is "1", this pin outputs a clock that is synchronous with SYNC. This pin outputs a 64 kHz clock when the G.711 mode or the G.726 mode has been selected, and outputs an 128 kHz clock when the 16-bit linear mode or G.729.A mode has been selected.

Note: The input/output control and frequencies of the above SYNC and BLCK signals will be as shown in Table 1 below.

CLKSEL	SYNC	BCLK	Remarks					
"0"	Input (8 kHz)	Input (64 kHz to 2048 kHz)	Input a continuous clock after starting the power supply. Input a 64 to 2048 kHz clock when G.711 or G.726 is selected. Input a 128 to 2048 kHz clock when 16-bit linear mode is selected.					
"1"	Output (8 kHz)	Output (64 kHz or 128 kHz)	An "L" level is output during the power down mode. A 64 kHz clock is output when G.711 or G.726 is selected. A 128 kHz clock is output when G.729.A or 16-bit linear mode is selected.					

Table 1 Input/output control of SYNC and BCLK

PCMO

This is the PCM signal output pin for the transmitting section. The PCM signal is output in synchronization with the rising edges of SYNC and BCLK. The PCMO outputs the data only during the valid data segment in the selected coding format and goes to the high impedance state during all other segments. The basic timing chart of the PCM I/F mode is shown in Fig. 11. The PCMO output will be in the high impedance state when the mutual conversion function is not used (CR11-B0 = "0") or when the PCM I/F mode is not used (CR12-B0 = "0").

PCMI

This is the PCM signal input pin for the receiving section. The data is entered starting from the MSB by shift on the falling edge of BCLK.

The basic timing chart of the PCM I/F mode is shown in Fig. 11.

Fix input with "0" or "1" when the mutual conversion function is not used (CR11-B0 = "0") or when the PCM I/F mode (CR12-B0 = "0") is not used.

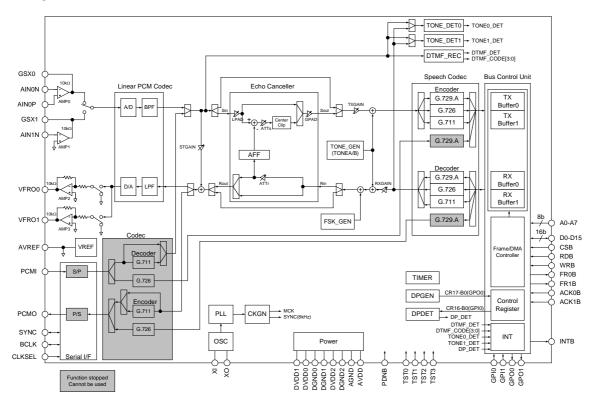
16-Bit I Long fr SYNC	inear ame synchronization mode (CR0-B1 = "0")	
(IN/OUT)		
BCLK (IN/OUT)		
PCMI	$\begin{array}{c} 0.000 \\$	
PCMO	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	
16-Bit li Short fr	inear ame synchronization mode (CR0-B1 = "1")	
SYNC		
(IN/OUT)		
BCLK (IN/OUT)		
PCMI	$\begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \\ \end{array} \end{array} \end{array} \end{array} \end{array} \\ \begin{array}{c} \begin{array}{c} \begin{array}{c} \end{array} \end{array} \end{array} \\ \begin{array}{c} \end{array} \end{array} \\ \end{array} \\ \begin{array}{c} \end{array} \end{array} \\ \begin{array}{c} \end{array} \end{array} \\ \begin{array}{c} \end{array} \end{array} \\ $	
PCMO	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	
	(μ-law, A-law) ame synchronization mode (CR0-B1 = "0")	
SYNC (IN/OUT)		
BCLK (IN/OUT)		
PCMI	D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D	
РСМО	Hi-z 6 8 8 6 6 6 7 6 6 7 6 7 7 Hi-z 6 8 6 6 7 6 7 7 7 Hi-z	
G.711 ((μ-law, A-law)	
	ame synchronization mode (CR0-B1 = "1")	
SYNC (IN/OUT)		
BCLK (IN/OUT)		
PCMI	D6 D6 D7 D7 D7 D7 D7 D7 D7 D7 D7 D7 D7 D7 D7	
PCMO	Hi-z Hi-z Hi-z Hi-z	
	(32 kbps)	
Long fra SYNC	ame synchronization mode (CR0-B1 = "0")	
(IN/OUT)		
BCLK (IN/OUT)		
PCMI		
PCMO	Hi-z 0 0 0 Hi-z Hi-z Hi-z	
	(32 kbps) rame synchronization mode (CR0-B1 = "1")	
SYNC		
(IN/OUT)		
BCLK (IN/OUT)		
PCMI	D1 D1 D2 D3 D3 D3 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1 D1	
D 0116	Hi-z Maro Hi-z Maro Hi-z	
PCMO		

Fig. 11 PCM I/F mode timing diagram

FUNCTION DESCRIPTION

Echo Canceller The block diagram of the echo canceller is shown in Fig. 39. **EXAMPLE OF CONFIGURATION**

Analog I/F mode



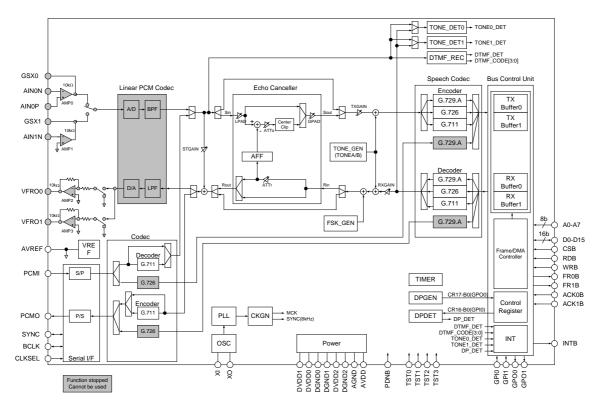
Example of settings in the initialization mode

- \cdot CR15 = 40h * This is mandatory.
- · CR6=01h,CR7=16h,CR8=00h,CR9=01h,CR1=80h (Address : 0116h, Data : 0001h)
- * This is mandatory. As for how to set them, refer to Method of Accessing and Controlling Internal Data Memory.

 \cdot CR11 = 00h (Frame/10 ms/16B/Speech CODEC = G.729.A)

- · Various settings
- \cdot CR0 = 09h (OPE_STAT = "1")

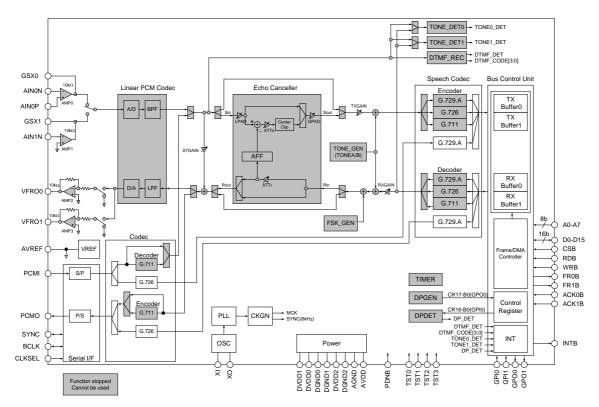
PCM I/F Mode



Examples of settings in the initialization mode

- \cdot CR15 = 40h * This is mandatory.
- · CR6=01h,CR7=16h,CR8=00h,CR9=01h,CR1=80h (Address : 0116h, Data : 0001h)
- * This is mandatory. As for how to set them, refer to Method of Accessing and Controlling Internal Data Memory.
- \cdot CR10 = 00h (VFRO1 = AVREF/VFRO0 = AVREF)
- \cdot CR11 = 00h (Frame/10 ms/16B/PCMIF = 16-bit linear)
- \cdot CR12 = 01h (Speech CODEC = G.729.A/PCMIF_EN = "1")
- · Various settings
- \cdot CR0 = 29h (AFE_EN = Power down/LONG/OPE_STAT = "1")

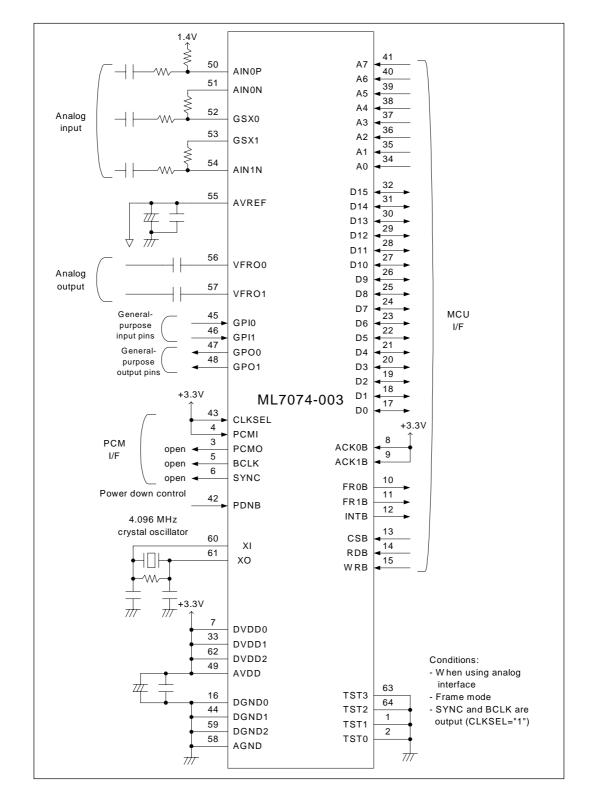
ML7074-003 GA



G.729.A ↔ G.726 Mutual Conversion

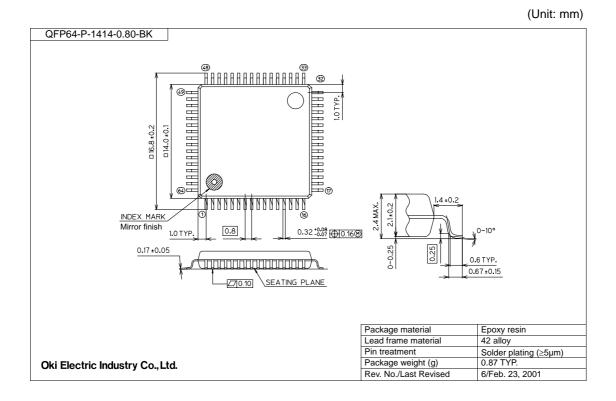
Examples of settings in the initialization mode

- \cdot CR15 = 40h * This is mandatory.
- · CR6=01h,CR7=16h,CR8=00h,CR9=01h,CR1=80h (Address : 0116h, Data : 0001h)
- * This is mandatory. As for how to set them, refer to Method of Accessing and Controlling Internal Data Memory.
- \cdot CR11 = 05h (Frame/10 ms/16B/G.726/TRANS_EN= "1")
- \cdot CR10 = 00h (VFRO1 = AVREF/VFRO0 = AVREF)
- · Various settings
- \cdot CR0 = 29h (AFE_EN = Power down/LONG/OPE_STAT = "1")



EXAMPLE OF APPLICATION CIRCUIT

PACKAGE DIMENSIONS



Notes for Mounting the Surface Mount Type Package

The surface mount type packages are very susceptible to heat in reflow mounting and humidity absorbed in storage.

Therefore, before you perform reflow mounting, contact Oki's responsible sales person for the product name, package name, pin number, package code and desired mounting conditions (reflow method, temperature and times).

FEDL7074-003FULL-01

OKI Semiconductor

ML7074-003 GA

REVISION HISTORY

Document		Page		
No.	Date	Previous Edition	Current Edition	Description
FEDL7074-003FULL-01	Oct. 27, 2003	-	-	Final edition 1

NOTICE

- 1. The information contained herein can change without notice owing to product and/or technical improvements. Before using the product, please make sure that the information being referred to is up-to-date.
- 2. The outline of action and examples for application circuits described herein have been chosen as an explanation for the standard action and performance of the product. When planning to use the product, please ensure that the external conditions are reflected in the actual circuit, assembly, and program designs.
- 3. When designing your product, please use our product below the specified maximum ratings and within the specified operating ranges including, but not limited to, operating voltage, power dissipation, and operating temperature.
- 4. Oki assumes no responsibility or liability whatsoever for any failure or unusual or unexpected operation resulting from misuse, neglect, improper installation, repair, alteration or accident, improper handling, or unusual physical or electrical stress including, but not limited to, exposure to parameters beyond the specified maximum ratings or operation outside the specified operating range.
- 5. Neither indemnity against nor license of a third party's industrial and intellectual property right, etc. is granted by us in connection with the use of the product and/or the information and drawings contained herein. No responsibility is assumed by us for any infringement of a third party's right which may result from the use thereof.
- 6. The products listed in this document are intended for use in general electronics equipment for commercial applications (e.g., office automation, communication equipment, measurement equipment, consumer electronics, etc.). These products are not authorized for use in any system or application that requires special or enhanced quality and reliability characteristics nor in any system or application where the failure of such system or application may result in the loss or damage of property, or death or injury to humans. Such applications include, but are not limited to, traffic and automotive equipment, safety devices, aerospace equipment, nuclear power control, medical equipment, and life-support systems.
- 7. Certain products in this document may need government approval before they can be exported to particular countries. The purchaser assumes the responsibility of determining the legality of export of these products and will take appropriate and necessary steps at their own expense for these.
- 8. No part of the contents contained herein may be reprinted or reproduced without our prior permission.

Copyright 2003 Oki Electric Industry Co., Ltd.